

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10737339	FANG ET AL.
	Examiner	Art Unit
	Haile, Awet A	2609

SEARCHED

Class	Subclass	Date	Examiner
370	203	10/12/2007	Awet Haile
370	208	10/12/2007	Awet Haile
370	210	10/12/2007	Awet Haile
370	260	10/12/2007	Awet Haile
370	281	10/12/2007	Awet Haile
370	392	10/12/2007	Awet Haile
370	393	10/12/2007	Awet Haile
370	474	10/12/2007	Awet Haile
370	475	10/12/2007	Awet Haile
370	476	10/12/2007	Awet Haile
370	480	10/12/2007	Awet Haile
708	00	10/12/2007	Awet Haile
375	00	10/12/2007	Awet Haile

SEARCH NOTES

Search Notes	Date	Examiner
Plus search	10/12/2007	Awet Haile
East search	10/12/2007	Awet Haile
Consult with Ian N moore	10/12/2007	Awet Haile
consult with Kwang Yao	10/12/2007	Awet Haile

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner